

Special sessions

Special session 1 Day 1 11:00-12:00 LT5

Debating the cost of psychological tests and the factors that determine the cost

Foxcroft, Cheryl (Nelson Mandela Metropolitan University, South Africa)

Bartram, Dave (SHL Group Ltd, United Kingdom)

Foster, David (Kryterion, Inc., USA)

Oakland, Tom (Department of Educational Psychology, University of Florida, USA)

Special session 2 Day 1 14:00-15:00 LT6

International Test Commission Guidelines for adapting educational and psychological tests (2nd edition)

Bartram, David (SHL Group, England)

Gregoire, Jacques (University of Louvain, Belgium)

Hambleton, Ronald (University of Massachusetts, Amherst, USA)

van de Vijver, Fons (University of Tilburg, the Netherlands)

Special session 3 Day 2 09:00-10:00 LT2

The international Journal of Testing: Ten Years and Going Strong

Hattie, John (University of Auckland, New Zealand)

Special session 4 Day 2 11:00-12:00 LT6

Examining Formative Assessment

Bennett, Randy (Educational Testing Service)

Brown, Gavin (The Hong Kong Institute of Education, Hong Kong)

Koh, Kim (Nanyang Technological University, Singapore)

Special session 5 Day 3 10:00-11:00 LT2

Informing about ISO 10667 - An International Standard for Assessment Service Delivery in Work and Organizational Settings

Born, Marise (Erasmus University Rotterdam, the Netherlands)

Bartram, Dave (SHL Group)

Nielsen, Sverre (The Norwegian Psychological Association, Norway)

Geisinger, Kurt (Buros Center on Testing & University of Nebraska, USA)

Tong, Alex (ATA Inc., China)

Harris, William G. (Association of Test Publishers, UAS)